

General Description

The 844003BI-01 is a 3 differential output LVDS Synthesizer designed to generate Ethernet reference clock frequencies. Using a 19.53125MHz or 25MHz, 18pF parallel resonant crystal, the following frequencies can be generated based on the settings of 4 frequency select pins (DIV_SELA[1:0], DIV_SELB[1:0]): 625MHz, 312.5MHz, 156.25MHz, and 125MHz. The 844003BI-01 has 2 output banks, Bank A with 1 differential LVDS output pair and Bank B with 2 differential LVDS output pairs.

The two banks have their own dedicated frequency select pins and can be independently set for the frequencies mentioned above. The 844003BI-01 uses IDT's 3rd generation low phase noise VCO technology and can achieve 1ps or lower typical rms phase jitter, easily meeting Ethernet jitter requirements. The 844003BI-01 is packaged in a small 24-pin TSSOP package.

Features

- Three differential LVDS output pairs on two banks, Bank A with one LVDS pair and Bank B with two LVDS output pairs
- Using a 19.53125MHz or 25MHz crystal, the two output banks can be independently set for 625MHz, 312.5MHz, 156.25MHz or 125MHz
- Selectable crystal oscillator interface or LVCMS/LVTTL single-ended input
- VCO range: 490MHz - 680MHz
- RMS phase jitter @ 156.25MHz (1.875MHz – 20MHz): 0.56ps (typical)
- Full 3.3V supply mode
- 40°C to 85°C ambient operating temperature
- Available in lead-free (RoHS 6) package

Pin Assignment

DIV_SELBO	1	24	DIV_SELB1
VCO_SEL	2	23	VDDO_B
MR	3	22	QB0
VDDO_A	4	21	nQB0
QA0	5	20	QB1
nQA0	6	19	nQB1
OEB	7	18	XTAL_SEL
OEA	8	17	REF_CLK
FB_DIV	9	16	XTAL_IN
VDDA	10	15	XTAL_OUT
VDD	11	14	GND
DIV_SELA0	12	13	DIV_SELA1

24-Lead TSSOP, E-Pad
4.40mm x 7.8mm x 0.925mm
package body
G Package

Block Diagram

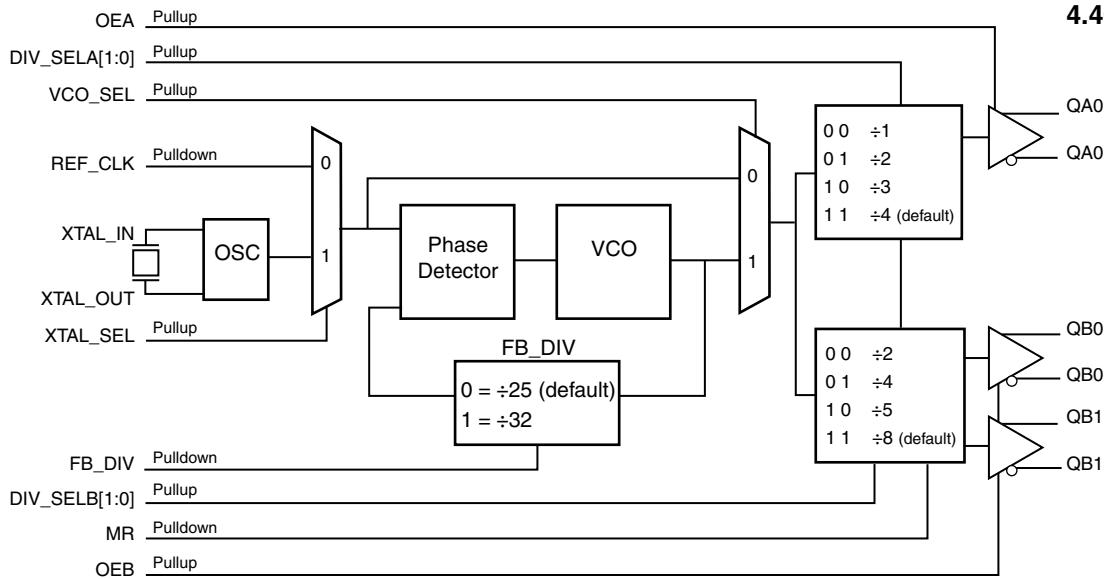


Table 1. Pin Descriptions

Number	Name	Type		Description
1, 24	DIV_SELB0, DIV_SELB1	Input	Pullup	Division select pin for Bank B. Default = HIGH. LVC MOS/LV TTL interface levels. See Table 3B.
2	VCO_SEL	Input	Pullup	VCO select pin. When Low, the PLL is bypassed and the crystal reference or REF_CLK (depending on XTAL_SEL setting) are passed directly to the output dividers. Has an internal pullup resistor so the PLL is not bypassed by default. LVC MOS/LV TTL interface levels.
3	MR	Input	Pulldown	Active HIGH Master Reset. When logic HIGH, the internal dividers are reset causing the true outputs Qx to go low and the inverted outputs nQx to go high. When logic LOW, the internal dividers and the outputs are enabled. Has an internal pulldown resistor so the power-up default state of outputs and dividers are enabled. LVC MOS/LV TTL interface levels.
4	V _{DDO_A}	Power		Output supply pin for Bank A outputs.
5, 6	QA0, nQA0	Output		Differential output pair. LVDS interface levels.
7	OEB	Input	Pullup	Output enable Bank B. Active High outputs are enable. When logic HIGH, the output pairs on Bank B are enabled. When logic LOW, the output pairs are in a high impedance state. Has an internal pullup resistor so the default power-up state of outputs are enabled. LVC MOS/LV TTL interface levels. See Table 3E.
8	OEA	Input	Pullup	Output enable Bank A. Active High output enable. When logic HIGH, the output pair in Bank A is enabled. When logic LOW, the output pair is in a high impedance state. Has an internal pullup resistor so the default power-up state of output is enabled. LVC MOS/LV TTL interface levels. See Table 3D.
9	FB_DIV	Input	Pulldown	Feedback divide select. When Low (default), the feedback divider is set for $\div 25$. When HIGH, the feedback divider is set for $\div 32$. See Table 3C. LVC MOS/LV TTL interface levels.
10	V _{DDA}	Power		Analog supply pin.
11	V _{DD}	Power		Core supply pin.
12, 13	DIV_SELA0, DIV_SELA1	Input	Pullup	Division select pin for Bank A. Default = HIGH. See Table 3A. LVC MOS/LV TTL interface levels.
14	GND	Power		Power supply ground.
15, 16	XTAL_OUT, XTAL_IN	Input		Parallel resonant crystal interface. XTAL_OUT is the output, XTAL_IN is the input. XTAL_IN is also the overdrive pin if you want to overdrive the crystal circuit with a single-ended reference clock.
17	REF_CLK	Input	Pulldown	Single-ended reference clock input. Has an internal pulldown resistor to pull to low state by default. Can leave floating if using the crystal interface. LVC MOS/LV TTL interface levels.
18	XTAL_SEL	Input	Pullup	Crystal select pin. Selects between the single-ended REF_CLK or crystal interface. Has an internal pullup resistor so the crystal interface is selected by default. LVC MOS/LV TTL interface levels.
19, 20	nQB1, QB1	Output		Differential output pair. LVDS interface levels.
21, 22	nQB0, QB0	Output		Differential output pair. LVDS interface levels.
23	V _{DDO_B}	Power		Output supply pin for Bank B outputs.

NOTE: *Pullup* and *Pulldown* refer to internal input resistors. See Table 2, *Pin Characteristics*, for typical values.

Table 2. Pin Characteristics

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
C_{IN}	Input Capacitance			4		pF
R_{PULLUP}	Input Pullup Resistor			51		k Ω
$R_{PULLDOWN}$	Input Pulldown Resistor			51		k Ω

Function Tables

Table 3A. Output Bank A Configuration
Select Function Table

Inputs		Outputs
DIV_SEL_A1	DIV_SEL_A0	QA0/ nQA0
0	0	$\div 1$
0	1	$\div 2$
1	0	$\div 3$
1	1	$\div 4$ (default)

Table 3D. OEA Select Function Table

Input	Outputs
OEA	QA0/ nQA0
0	High Impedance
1	Active (default)

Table 3C. Feedback Divider Configuration
Select Function Table

Input	
FB_DIV	Feedback Divide
0	$\div 25$ (default)
1	$\div 32$

Table 3E. OEB Select Function Table

Input	Outputs
OEB	QB[0:1]/ nQB[0:1]
0	High Impedance
1	Active (default)

Table 3B. Output Bank B Configuration
Select Function Table

Inputs		Outputs
DIV_SEL_B1	DIV_SEL_B0	QB[0:1]/ nQB[0:1]
0	0	$\div 2$
0	1	$\div 4$
1	0	$\div 5$
1	1	$\div 8$ (default)

Table 3F. Bank A Frequency Table

Inputs				Feedback Divider	Bank A Output Divider	M/N Multiplication Factor	QA0/ nQA0 Output Frequency (MHz)
Crystal Frequency (MHz)	FB_DIV	DIV_SELA1	DIV_SELA0				
25	0	0	0	25	1	25	625
25	0	0	1	25	2	12.5	312.5
20	0	0	1	25	2	12.500	250
22.5	0	1	0	25	3	8.333	187.5
25	0	1	1	25	4	6.25	156.25
24	0	1	1	25	4	6.25	150
20	0	1	1	25	4	6.25	125
19.44	1	0	0	32	1	32	622.08
19.44	1	0	1	32	2	16	311.04
15.625	1	0	1	32	2	16	250
18.75	1	1	0	32	3	10.667	200
19.44	1	1	1	32	4	8	155.52
18.75	1	1	1	32	4	8	150
15.625	1	1	1	32	4	8	125

Table 3G. Bank B Frequency Table

Inputs				Feedback Divider	Bank B Output Divider	M/N Multiplication Factor	QBx/ nQBx Output Frequency (MHz)
Crystal Frequency (MHz)	FB_DIV	DIV_SELB1	DIV_SELB0				
25	0	0	0	25	2	12.5	312.5
20	0	0	0	25	2	12.5	250
25	0	0	1	25	4	6.25	156.25

Inputs				Feedback Divider	Bank B Output Divider	M/N Multiplication Factor	QBx/ nQBx Output Frequency (MHz)
Crystal Frequency (MHz)	FB_DIV	DIV_SELB1	DIV_SELB0				
24	0	0	1	25	4	6.25	150
20	0	0	1	25	4	6.25	125
25	0	1	0	25	5	5	125
25	0	1	1	25	8	3.125	78.125
24	0	1	1	25	8	3.125	75
20	0	1	1	25	8	3.125	62.5
19.44	1	0	0	32	2	16	311.04
15.625	1	0	0	32	2	16	250
19.44	1	0	1	32	4	8	155.52
18.75	1	0	1	32	4	8	150
15.625	1	0	1	32	4	8	125
15.625	1	1	0	32	5	6.4	100
19.44	1	1	1	32	8	4	77.76
18.75	1	1	1	32	8	4	75
15.625	1	1	1	32	8	4	62.5

Absolute Maximum Ratings

NOTE: Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of product at these conditions or any conditions beyond those listed in the *DC Characteristics* or *AC Characteristics* is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

Item	Rating
Supply Voltage, V_{DD}	4.6V
Inputs, V_I	-0.5V to $V_{DD} + 0.5V$
Outputs, I_O Continuous Current Surge Current	10mA 15mA
Package Thermal Impedance, θ_{JA}	37°C/W (0 mps)
Storage Temperature, T_{STG}	-65°C to 150°C

DC Electrical Characteristics

Table 4A. Power Supply DC Characteristics, $V_{DD} = V_{DDA} = V_{DDO_A} = V_{DDO_B} = 3.3V \pm 5\%$, $T_A = -40^\circ C$ to $85^\circ C$

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V_{DD}	Positive Supply Voltage		3.135	3.3	3.465	V
V_{DDA}	Analog Supply Voltage		3.135	3.3	3.465	V
V_{DDO_A}, V_{DDO_B}	Output Supply Voltage		3.135	3.3	3.465	V
I_{DD}	Power Supply Current				135	mA
I_{DDA}	Analog Supply Current				12	mA
$I_{DDO_A} + I_{DDO_B}$	Output Supply Current				80	mA

Table 4B. LVCMOS/LVTTL DC Characteristics, $V_{DD} = V_{DDA} = V_{DDO_A} = V_{DDO_B} = 3.3V \pm 5\%$, $T_A = -40^\circ C$ to $85^\circ C$

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V_{IH}	Input High Voltage		2		$V_{DD} + 0.3$	V
V_{IL}	Input Low Voltage		-0.3		0.8	V
I_{IH}	Input High Current	REF_CLK, MR, FB_DIV	$V_{DD} = V_{IN} = 3.465V$		150	μA
		DIV_SELA[0:1], OEA, OEB, DIV_SELB[0:1], VCO_SEL, XTAL_SEL	$V_{DD} = V_{IN} = 3.465V$		5	μA
I_{IL}	Input Low Current	REF_CLK, MR, FB_DIV	$V_{DD} = 3.465V, V_{IN} = 0V$	-5		μA
		DIV_SELA[0:1], OEA, OEB, DIV_SELB[0:1], VCO_SEL, XTAL_SEL	$V_{DD} = 3.465V, V_{IN} = 0V$	-150		μA

Table 4C. LVDS DC Characteristics, $V_{DD} = V_{DDA} = V_{DDO_A} = V_{DDO_B} = 3.3V \pm 5\%$, $T_A = -40^\circ\text{C}$ to 85°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V_{OD}	Differential Output Voltage		250		450	mV
ΔV_{OD}	V_{OD} Magnitude Change				50	mV
V_{OS}	Offset Voltage		1.25	1.33	1.41	V
ΔV_{OS}	V_{OS} Magnitude Change				50	mV

Table 5. Crystal Characteristics

Parameter		Test Conditions	Minimum	Typical	Maximum	Units
Mode of Oscillation			Fundamental			
Frequency	FB_DIV = $\div 25$		19.6		27.2	MHz
	FB_DIV = $\div 32$		15.313		21.25	MHz
Equivalent Series Resistance (ESR)					50	Ω
Shunt Capacitance					7	pF
Drive Level					1	mW

AC Electrical Characteristics

Table 6. AC Characteristics, $V_{DD} = V_{DDA} = V_{DDO_A} = V_{DDO_B} = 3.3V \pm 5\%$, $T_A = -40^\circ\text{C}$ to 85°C

Parameter	Symbol	Test Conditions		Minimum	Typical	Maximum	Units
f_{OUT}	Output Frequency Range	Output Divider = $\div 1$	490			680	MHz
		Output Divider = $\div 2$	245			340	MHz
		Output Divider = $\div 3$	163.33			226.67	MHz
		Output Divider = $\div 4$	122.5			170	MHz
		Output Divider = $\div 5$	98			136	MHz
		Output Divider = $\div 8$	61.25			85	MHz
$t_{SK(b)}$	Bank Skew; NOTE 1					33	ps
$t_{SK(o)}$	Output Skew	NOTE 2, 3	Outputs @ Same Frequency			75	ps
		NOTE 2, 3, 4	Outputs @ Different Frequencies			170	ps
$t_{JIT}(\emptyset)$	RMS Phase Jitter (Random); NOTE 5	625MHz (1.875MHz – 20MHz)		0.53			ps
		312.5MHz (1.875MHz – 20MHz):		0.53			ps
		156.25MHz (1.875MHz – 20MHz)		0.56			ps
		125MHz (1.875MHz – 20MHz)		0.58			ps
t_R / t_F	Output Rise/Fall Time	20% to 80%	200			450	ps
odc	Output Duty Cycle	Output Divider $\neq \div 1$	47			53	%
		Output Divider = $\div 1$	43			57	%

NOTE 1: Defined as skew within a bank of outputs at the same voltages and with equal load conditions.

NOTE 2: Defined as skew between outputs at the same supply voltages and with equal load conditions.

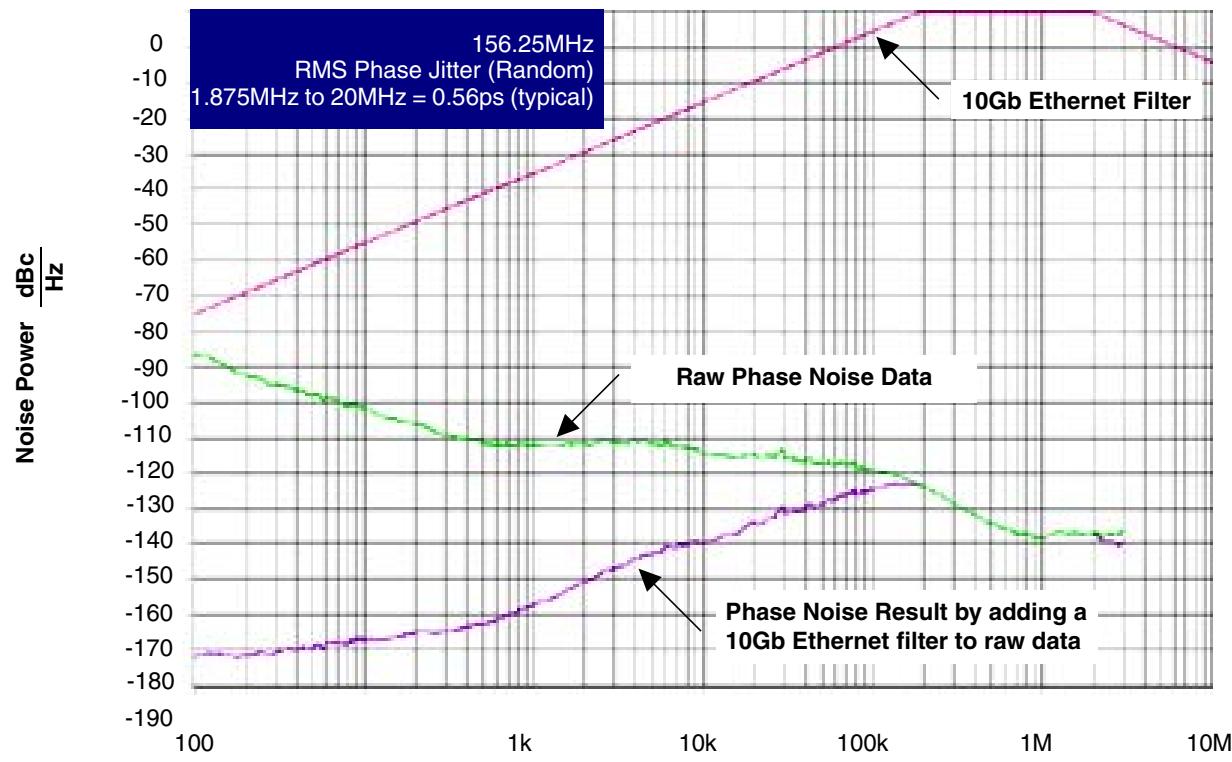
Measured at the output differential cross points.

NOTE 3: This parameter is defined in accordance with JEDEC Standard 65.

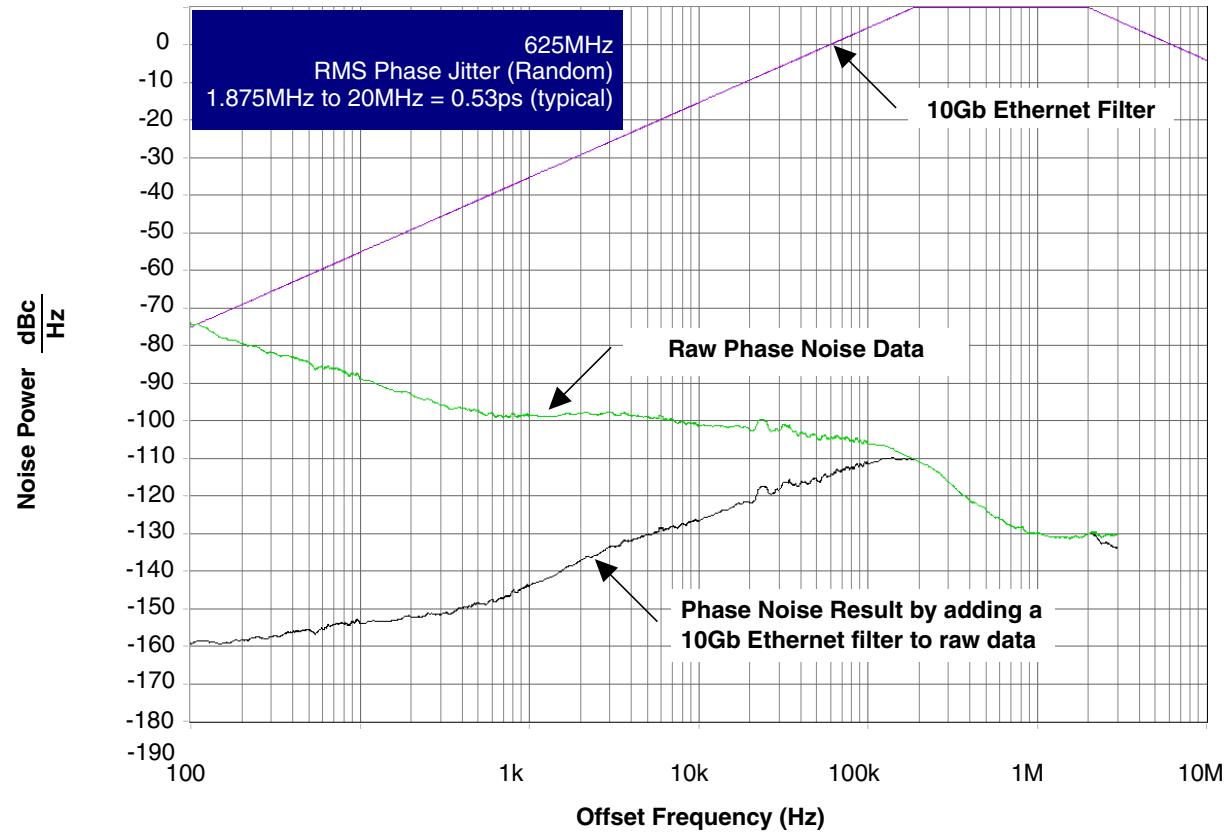
NOTE 4: Characterized using output dividers 1, 2, 4, 8.

NOTE 5: Refer to the Phase Noise Plots.

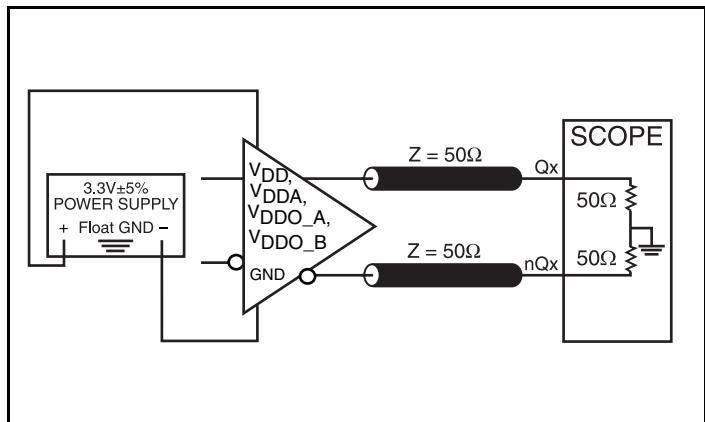
Typical Phase Noise at 156.25MHz



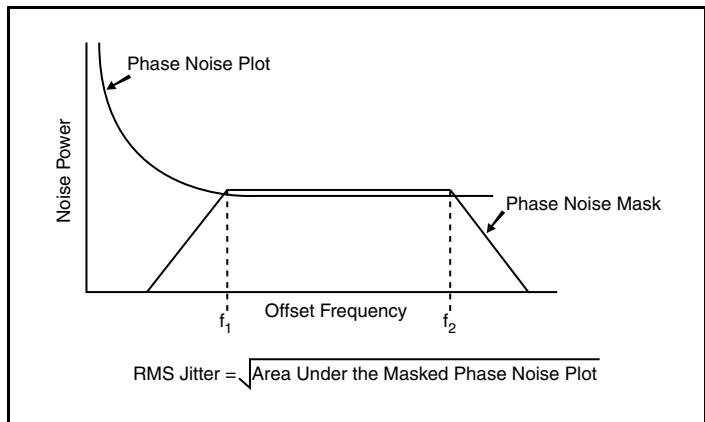
Typical Phase Noise at 625MHz



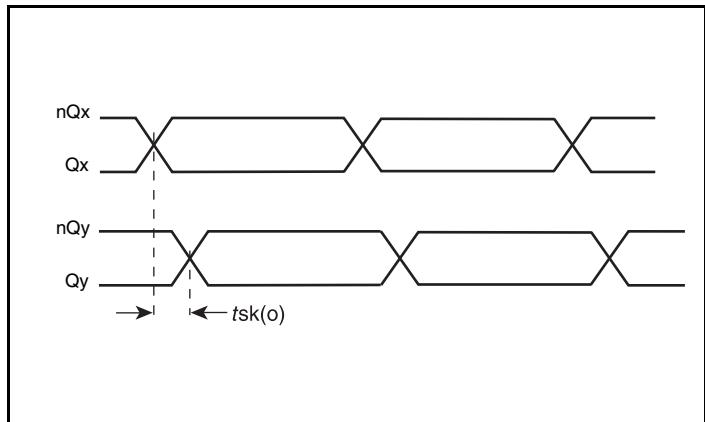
Parameter Measurement Information



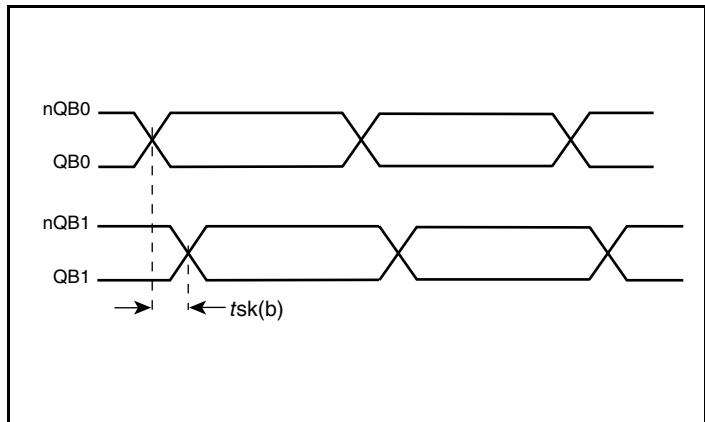
3.3V LVDS Output Load AC Test Circuit



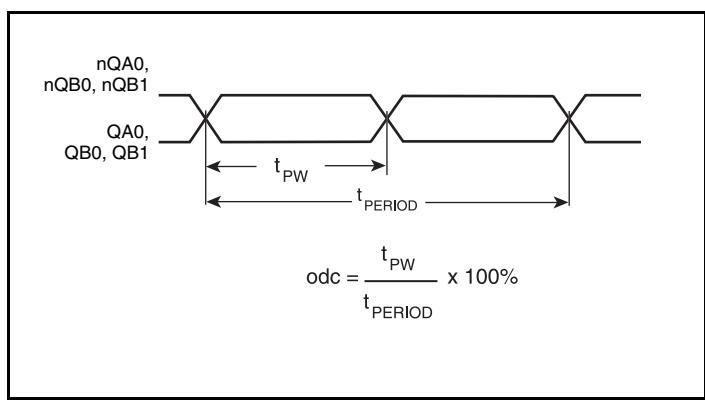
RMS Phase Jitter



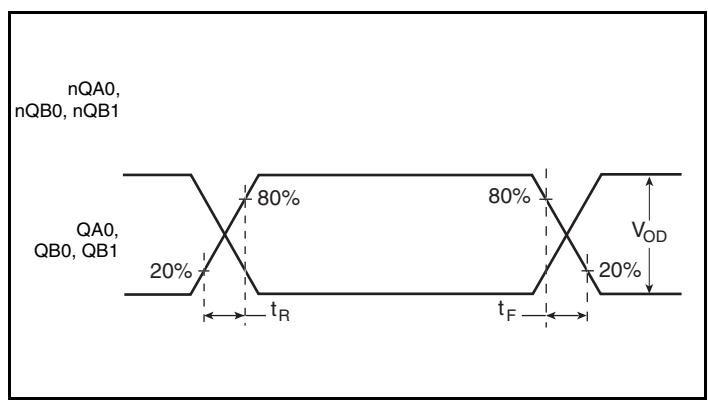
Output Skew



Bank Skew

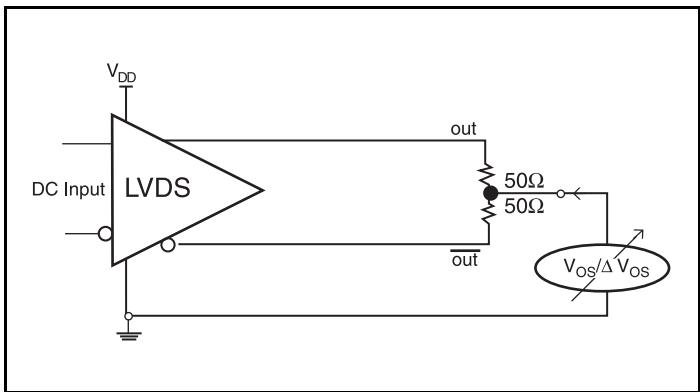


Output Duty Cycle/Pulse Width/Period

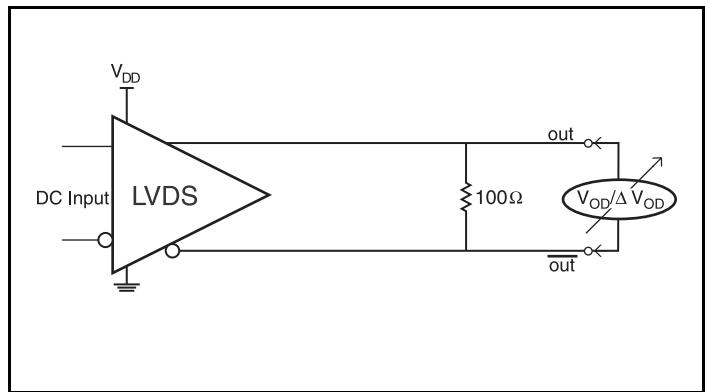


Output Rise/Fall Time

Parameter Measurement Information, continued



Offset Voltage Setup



Differential Output Voltage Setup

Application Information

Power Supply Filtering Technique

As in any high speed analog circuitry, the power supply pins are vulnerable to random noise. To achieve optimum jitter performance, power supply isolation is required. The 844003BI-01 provides separate power supplies to isolate any high switching noise from the outputs to the internal PLL. V_{DD} , V_{DDA} , V_{DDO_A} and V_{DDO_B} should be individually connected to the power supply plane through vias, and $0.01\mu F$ bypass capacitors should be used for each pin. Figure 1 illustrates this for a generic V_{DD} pin and also shows that V_{DDA} requires that an additional 10Ω resistor along with a $10\mu F$ bypass capacitor be connected to the V_{DDA} pin.

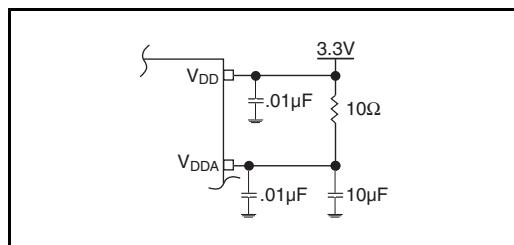


Figure 1. Power Supply Filtering

Crystal Input Interface

The 844003BI-01 has been characterized with 18pF parallel resonant crystals. The capacitor values shown in *Figure 2* below

were determined using a 19.53125MHz or 25MHz, 18pF parallel resonant crystal and were chosen to minimize the ppm error.

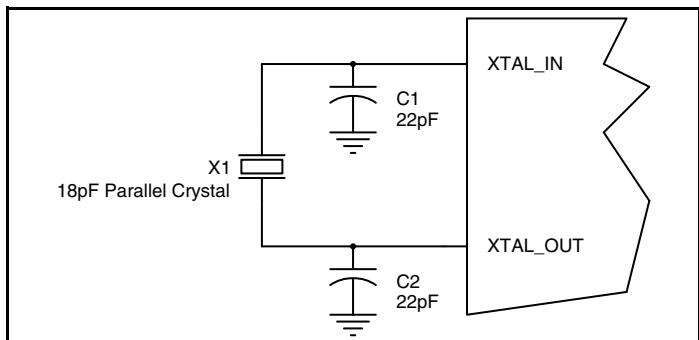


Figure 2. Crystal Input Interface

Overdriving the XTAL Interface

The XTAL_IN input can be overdriven by an LVCMS driver or by one side of a differential driver through an AC coupling capacitor. The XTAL_OUT pin can be left floating. The amplitude of the input signal should be between 500mV and 1.8V and the slew rate should not be less than 0.2V/ns. For 3.3V LVCMS inputs, the amplitude must be reduced from full swing to at least half the swing in order to prevent signal interference with the power rail and to reduce internal noise. *Figure 3A* shows an example of the interface diagram for a high speed 3.3V LVCMS driver. This configuration requires that the sum of the output impedance of the driver (Z_o) and the series resistance (R_s) equals the transmission line impedance. In addition, matched termination at the crystal input will attenuate the signal in half. This

can be done in one of two ways. First, R_1 and R_2 in parallel should equal the transmission line impedance. For most 50Ω applications, R_1 and R_2 can be 100Ω . This can also be accomplished by removing R_1 and changing R_2 to 50Ω . The values of the resistors can be increased to reduce the loading for a slower and weaker LVCMS driver. *Figure 3A* shows an example of the interface diagram for an LVPECL driver. This is a standard LVPECL termination with one side of the driver feeding the XTAL_IN input. It is recommended that all components in the schematics be placed in the layout. Though some components might not be used, they can be utilized for debugging purposes. The datasheet specifications are characterized and guaranteed by using a quartz crystal as the input.

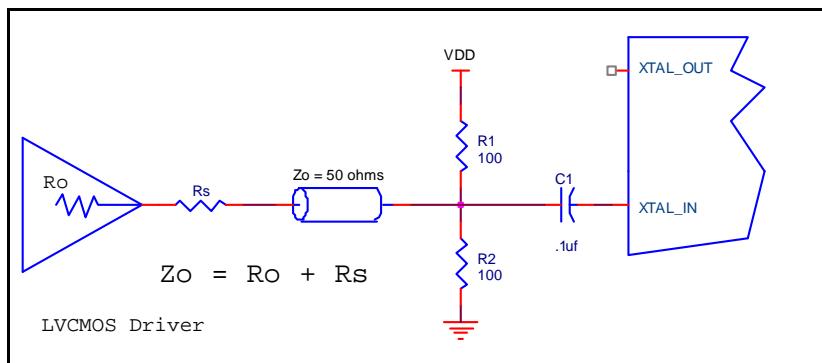


Figure 3A. General Diagram for LVCMS Driver to XTAL Input Interface

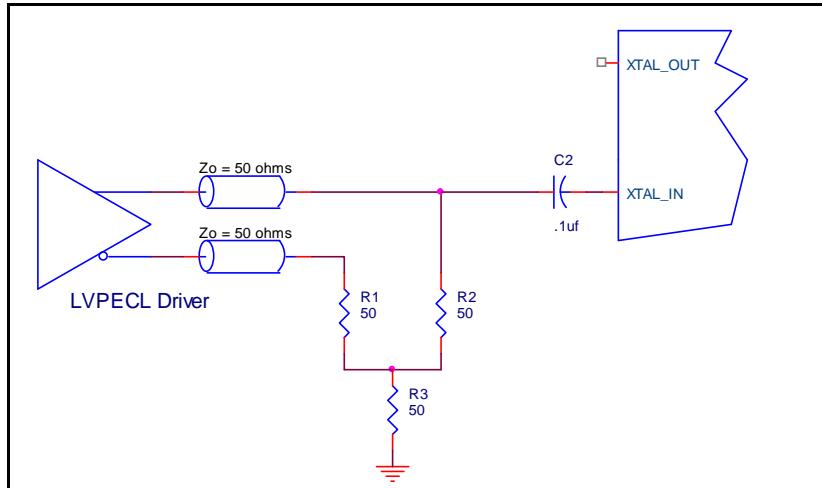


Figure 3A. General Diagram for LVPECL Driver to XTAL Input Interface

Recommendations for Unused Input and Output Pins

Inputs:

Crystal Inputs

For applications not requiring the use of the crystal oscillator input, both XTAL_IN and XTAL_OUT can be left floating. Though not required, but for additional protection, a $1\text{k}\Omega$ resistor can be tied from XTAL_IN to ground.

REF_CLK Input

For applications not requiring the use of the reference clock, it can be left floating. Though not required, but for additional protection, a $1\text{k}\Omega$ resistor can be tied from the REF_CLK to ground.

LVC MOS Control Pins

All control pins have internal pullups or pulldowns; additional resistance is not required but can be added for additional protection. A $1\text{k}\Omega$ resistor can be used.

Outputs:

LVDS Outputs

All unused LVDS output pairs can be either left floating or terminated with 100Ω across. If they are left floating, we recommend that there is no trace attached.

LVDS Driver Termination

For a general LVDS interface, the recommended value for the termination impedance (Z_T) is between 90Ω and 132Ω . The actual value should be selected to match the differential impedance (Z_0) of your transmission line. A typical point-to-point LVDS design uses a 100Ω parallel resistor at the receiver and a 100Ω differential transmission-line environment. In order to avoid any transmission-line reflection issues, the components should be surface mounted and must be placed as close to the receiver as possible. IDT offers a full line of LVDS compliant devices with two types of output structures: current source and voltage source. The standard termination schematic as shown in [Figure 4A](#) can be used

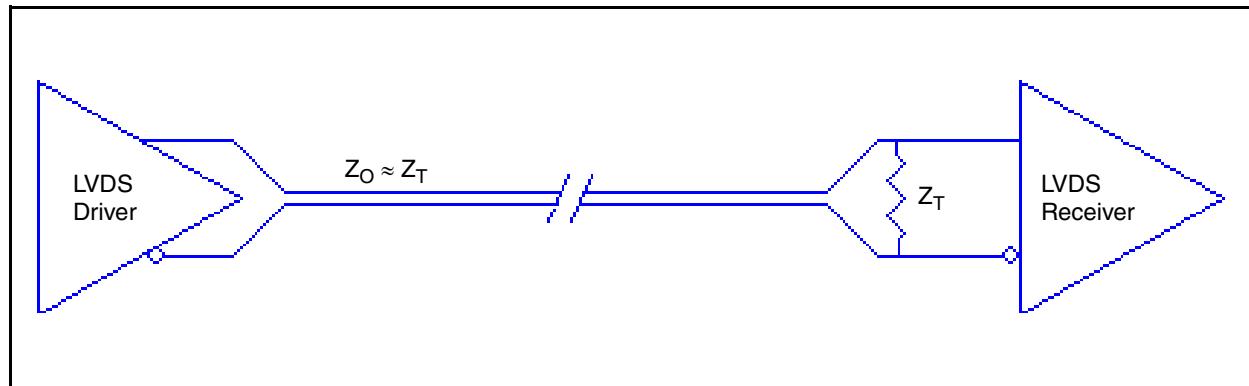


Figure 4A Standard LVDS Termination

with either type of output structure. [Figure 4B](#), which can also be used with both output types, is an optional termination with center tap capacitance to help filter common mode noise. The capacitor value should be approximately 50pF . If using a non-standard termination, it is recommended to contact IDT and confirm if the output structure is current source or voltage source type. In addition, since these outputs are LVDS compatible, the input receiver's amplitude and common-mode input range should be verified for compatibility with the output.

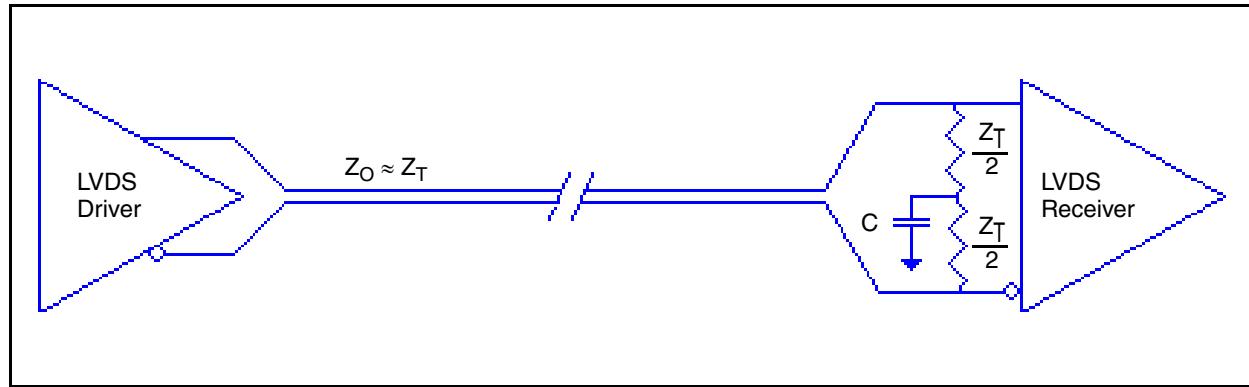


Figure 4B Optional LVDS Termination

EPAD Thermal Release Path

In order to maximize both the removal of heat from the package and the electrical performance, a land pattern must be incorporated on the Printed Circuit Board (PCB) within the footprint of the package corresponding to the exposed metal pad or exposed heat slug on the package, as shown in *Figure 5*. The solderable area on the PCB, as defined by the solder mask, should be at least the same size/shape as the exposed pad/slug area on the package to maximize the thermal/electrical performance. Sufficient clearance should be designed on the PCB between the outer edges of the land pattern and the inner edges of pad pattern for the leads to avoid any shorts.

While the land pattern on the PCB provides a means of heat transfer and electrical grounding from the package to the board through a solder joint, thermal vias are necessary to effectively conduct from the surface of the PCB to the ground plane(s). The land pattern must be connected to ground through these vias. The vias act as "heat pipes". The number of vias (i.e. "heat pipes") are application specific

and dependent upon the package power dissipation as well as electrical conductivity requirements. Thus, thermal and electrical analysis and/or testing are recommended to determine the minimum number needed. Maximum thermal and electrical performance is achieved when an array of vias is incorporated in the land pattern. It is recommended to use as many vias connected to ground as possible. It is also recommended that the via diameter should be 12 to 13mils (0.30 to 0.33mm) with 1oz copper via barrel plating. This is desirable to avoid any solder wicking inside the via during the soldering process which may result in voids in solder between the exposed pad/slug and the thermal land. Precautions should be taken to eliminate any solder voids between the exposed heat slug and the land pattern. Note: These recommendations are to be used as a guideline only. For further information, refer to the Application Note on the *Surface Mount Assembly* of Amkor's Thermally/Electrically Enhance Leadframe Base Package, Amkor Technology.

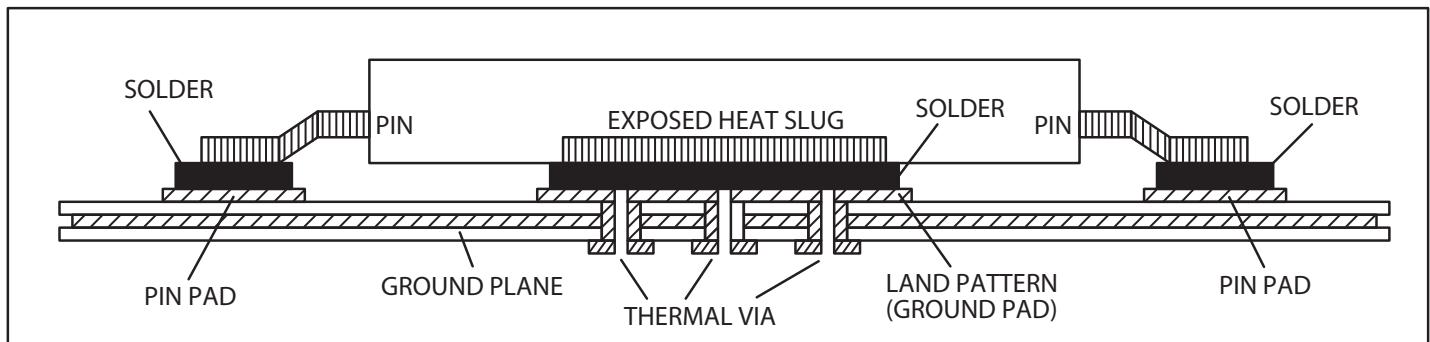


Figure 5. Assembly for Exposed Pad Thermal Release Path - Side View (drawing not to scale)

Package Outline and Package Dimensions

Package Outline - G Suffix for 24 Lead TSSOP, E-Pad

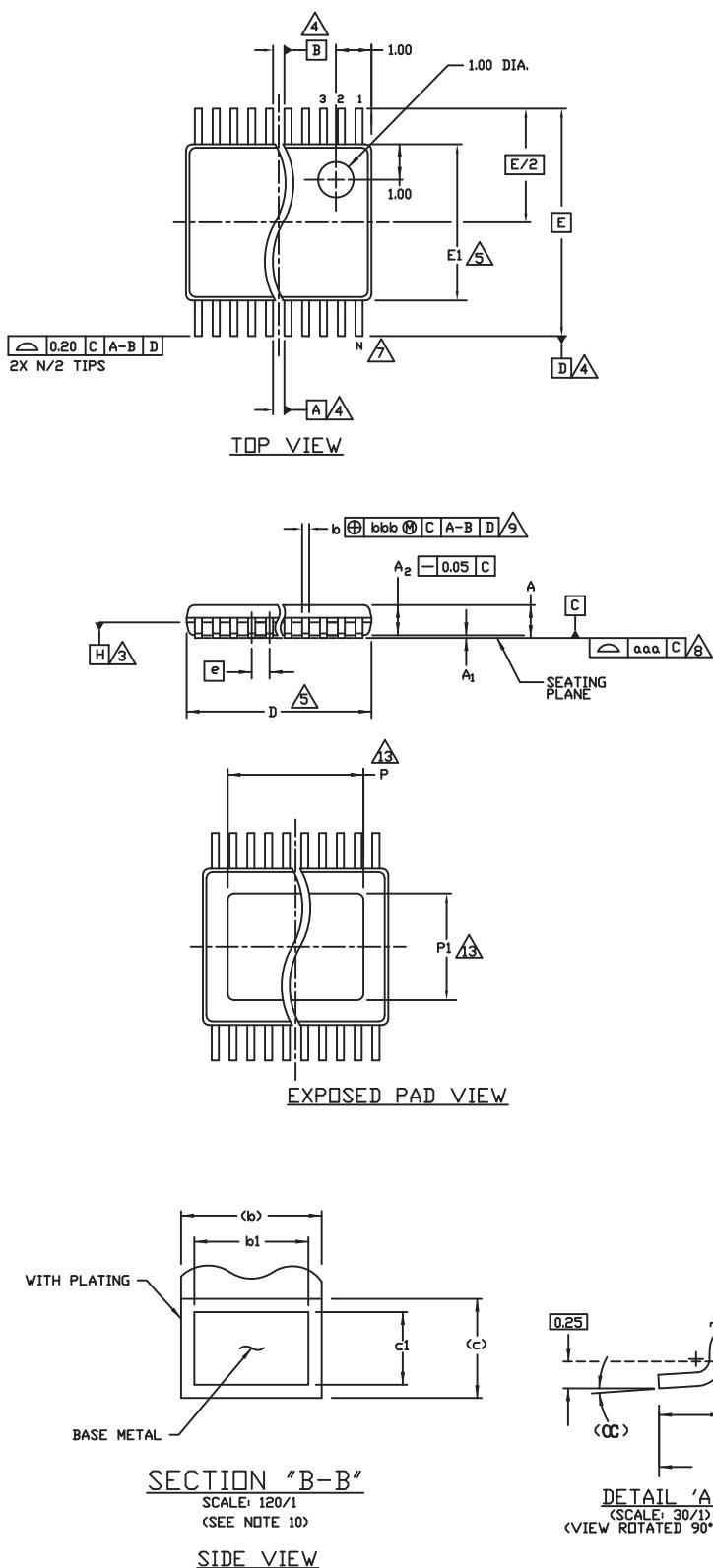


Table 9. Package Dimensions

All Dimensions in Millimeters			
Symbol	Minimum	Nominal	Maximum
N	24		
A		1.10	
A1	0.05		0.15
A2	0.85	0.90	0.95
b	0.19		0.30
b1	0.19	0.22	0.25
c	0.09		0.20
c1	0.09	0.127	0.16
D	7.70		7.90
E	6.40 Basic		
E1	4.30	4.40	4.50
e	0.65 Basic		
L	0.50	0.60	0.70
P	5.0		5.5
P1	3.0		3.2
α	0°		8°
$\alpha\alpha\alpha$	0.076		
bbb	0.10		

Power Considerations

This section provides information on power dissipation and junction temperature for the 844003BI-01. Equations and example calculations are also provided.

1. Power Dissipation.

The total power dissipation for the 844003BI-01 is the sum of the core power plus the analog power plus the power dissipated in the load(s). The following is the power dissipation for $V_{DD} = 3.3V + 5\% = 3.465V$, which gives worst case results.

NOTE: Please refer to Section 3 for details on calculating power dissipated in the load.

- Power (core)_{MAX} = $V_{DD_MAX} * (I_{DD_MAX} + I_{DDA_MAX}) = 3.465V * (135mA + 12mA) = 509.36\text{mW}$
- Power (outputs)_{MAX} = $V_{DDO_MAX} * I_{DDO_MAX} = 3.465V * 80mA = 277.20\text{mW}$

Total Power_{MAX} = 509.36mW + 277.20mW = **786.56mW**

2. Junction Temperature.

Junction temperature, T_j , is the temperature at the junction of the bond wire and bond pad and directly affects the reliability of the device. The maximum recommended junction temperature for HiPerClockS devices is 125°C.

The equation for T_j is as follows: $T_j = \theta_{JA} * P_{d_total} + T_a$

T_j = Junction Temperature

θ_{JA} = Junction-to-Ambient Thermal Resistance

P_{d_total} = Total Device Power Dissipation (example calculation is in section 1 above)

T_a = Ambient Temperature

In order to calculate junction temperature, the appropriate junction-to-ambient thermal resistance θ_{JA} must be used. Assuming a moderate air flow of 1 meter per second and a multi-layer board, the appropriate value is 31°C/W per Table 7 below.

Therefore, T_j for an ambient temperature of 85°C with all outputs switching is:

$85^\circ\text{C} + 0.787\text{W} * 31^\circ\text{C/W} = 109.4^\circ\text{C}$. This is below the limit of 125°C.

This calculation is only an example. T_j will obviously vary depending on the number of loaded outputs, supply voltage, air flow and the type of board.

Table 7. Thermal Resistance θ_{JA} for 24 Lead TSSOP, E-Pad, Forced Convection

θ_{JA} by Velocity			
Meters per Second	0	1	2
Multi-Layer PCB, JEDEC Standard Test Boards	37°C/W	31°C/W	30°C/W

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Table 8. θ_{JA} vs. Air Flow Table for a 24 Lead TSSOP, E-Pad

θ_{JA} by Velocity			
Meters per Second	0	1	2
Multi-Layer PCB, JEDEC Standard Test Boards	37°C/W	31°C/W	30°C/W

Transistor Count

The transistor count for 844003BI-01 is: 3537

Ordering Information

Table 10. Ordering Information

Part/Order Number	Marking	Package	Shipping Packaging	Temperature
844003BGI-01LF	ICS44003BI01L	"Lead-Free" 24 Lead TSSOP, E-Pad	Tube	-40°C to 85°C
844003BGI-01LFT	ICS44003BI01L	"Lead-Free" 24 Lead TSSOP, E-Pad	2500 Tape & Reel	-40°C to 85°C

NOTE: Parts that are ordered with an "LF" suffix to the part number are the Pb-Free configuration and are RoHS compliant.

Revision History Sheet

Rev	Table	Page	Description of Change	Date
A	T1	2	Pin Characteristics - added pin numbers 17– 23 to the table.	08/20/08
	T5	7	Crystal Characteristics - moved 15.315MHz min. from ESR row to Frequency ÷32 row.	
	T6	8	AC Characteristics - added test conditions to f_{OUT} rows and filled in Units column.	
		14	Updated Thermal Release Path section.	
B	T10	18	Ordering Information - removed leaded devices PDN CQ-13-02. Updated datasheet format	12/18/14

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